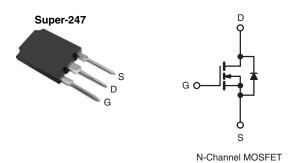
Vishay Siliconix

## **D Series Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V) at T <sub>J</sub> max. 550				
R <sub>DS(on)</sub> max. at 25 °C (Ω)	V <sub>GS</sub> = 10 V	0.130		
Q <sub>g</sub> max. (nC)	125			
Q <sub>gs</sub> (nC)	23			
Q <sub>gd</sub> (nC)	37			
Configuration	Single			



### **FEATURES**

- Optimal Design
  - Low Area specific On-Resistance
  - Low Input Capacitance (Ciss)
  - Reduced Capacitive Switching Losses
  - High Body Diode Ruggedness
  - Avalanche Energy Rated (UIS)
- · Optimal Efficiency and Operation
  - Low Cost
  - Simple Gate Drive Circuitry
  - Low Figure-Of-Merit (FOM): Ron x Qa
  - Fast Switching
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912

### **APPLICATIONS**

- Consumer Electronics
  - Displays (LCD or Plasma TV
- Server and Telecom Power Supplies
  - SMPS
- Industrial
  - Welding, Induction Heating, Motor Drives
- · Battery Chargers

ORDERING INFORMATION	
Package	Super-247
Lead (Pb)-free	SiHS36N50D-E3

PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V <sub>DS</sub>	500	
Gate-Source Voltage			V	± 30	V
Gate-Source Voltage AC (f > 1 Hz)			V <sub>GS</sub>	30	
Continuous Drain Current (T,I = 150 °C)	V <sub>GS</sub> at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		36	А
Continuous Drain Current (1) = 130 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	l <sub>D</sub>	23	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	112	
Linear Derating Factor				3.6	W/°C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	332	mJ
Maximum Power Dissipation			P <sub>D</sub>	446	W
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Drain-Source Voltage Slope T <sub>J</sub> = 125 °C		dV/dt	24	1//	
Reverse Diode dV/dt <sup>d</sup>			uv/di	0.1	- V/ns
Soldering Recommendations (Peak Temperature) for 10 s			300°	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=50$  V, starting  $T_J=25$  °C, L=2.3 mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=17$  A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , starting  $T_J = 25$  °C.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.28	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 250 μA	-	0.52	-	V/°C
Gate Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
		V <sub>DS</sub> =	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 18 A	-	0.105	0.130	Ω
Forward Transconductancea	9 <sub>fs</sub>	V <sub>DS</sub>	= 50 V, I <sub>D</sub> = 18 A	-	12.8	-	S
Dynamic				l	1		
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	3233	-	
Output Capacitance	C <sub>oss</sub>	1	$V_{DS} = 100 \text{ V},$	-	285	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		-	25	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 V to 400 V		-	240	-	pF
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	352	-	-
Total Gate Charge	Qg			-	83	125	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 18 \text{ A}, V_{DS} = 400 \text{ V}$	-	23	-	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	37	-	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 400 \text{ V}, I_{D} = 18 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		-	33	66	
Rise Time	t <sub>r</sub>			-	89	134	ns
Turn-Off Delay Time	$t_{d(off)}$			-	79	119	115
Fall Time	t <sub>f</sub>			-	68	102	
Gate Input Resistance	$R_g$	f = 1	MHz, open drain		1.8	-	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	36	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	144	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 18 A, V <sub>GS</sub> = 0 V		-	-	1.2	V
Reverse Recovery Time	t <sub>rr</sub>			-	490	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 18 \text{ A},$ $dI/dt = 100 \text{ A/µs}, V_R = 20 \text{ V}$		-	8.2	-	μC
Reverse Recovery Current	I <sub>RRM</sub>			_	31	_	A

### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

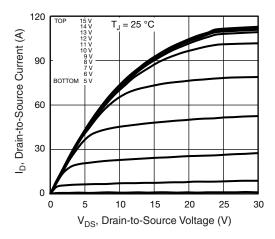


Fig. 1 - Typical Output Characteristics

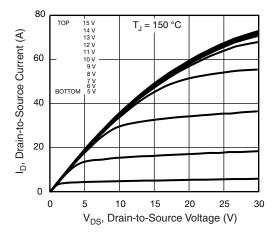


Fig. 2 - Typical Output Characteristics

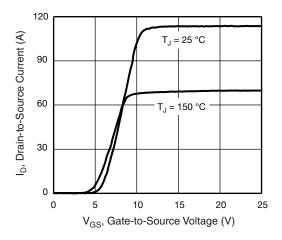


Fig. 3 - Typical Transfer Characteristics

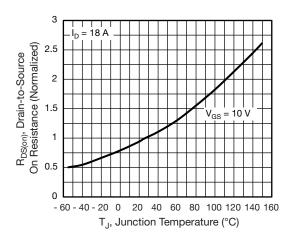


Fig. 4 - Normalized On-Resistance vs. Temperature

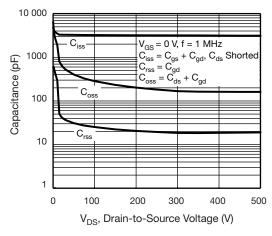


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

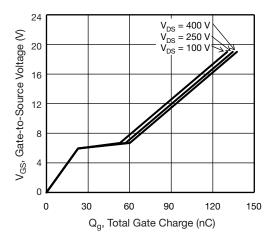


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

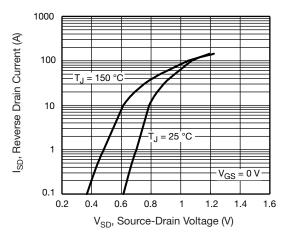


Fig. 7 - Typical Source-Drain Diode Forward Voltage

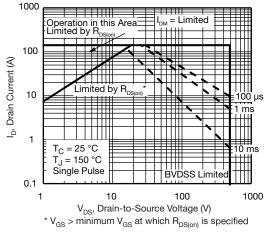


Fig. 8 - Maximum Safe Operating Area

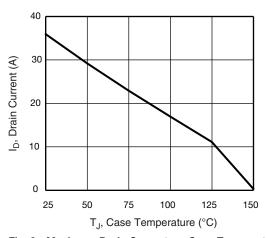


Fig. 9 - Maximum Drain Current vs. Case Temperature

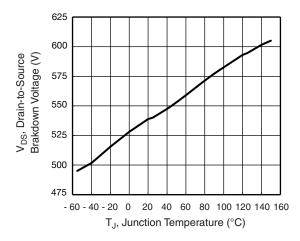


Fig. 10 - Temperature vs. Drain-to-Source Voltage

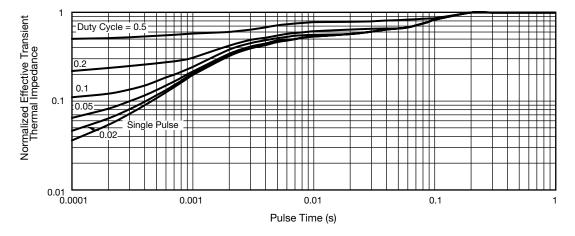


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



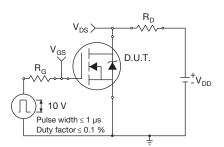


Fig. 12 - Switching Time Test Circuit

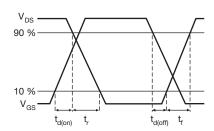


Fig. 13 - Switching Time Waveforms

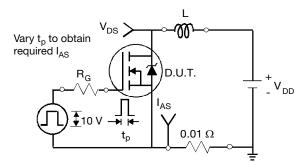


Fig. 14 - Unclamped Inductive Test Circuit

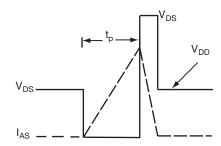


Fig. 15 - Unclamped Inductive Waveforms

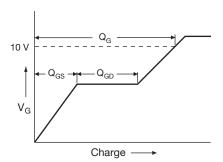


Fig. 16 - Basic Gate Charge Waveform

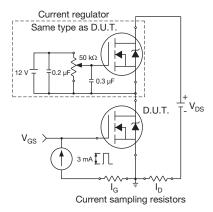
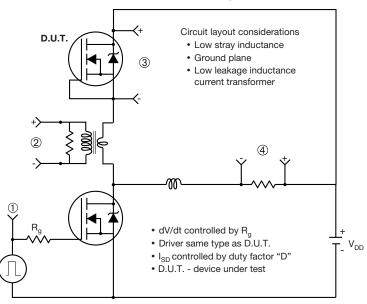


Fig. 17 - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



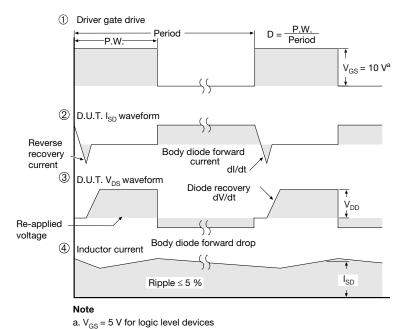


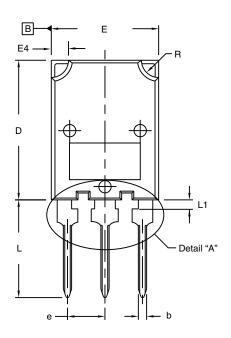
Fig. 18 - For N-Channel

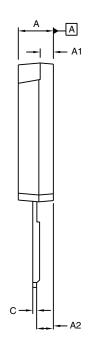
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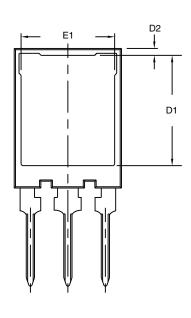


# **TO-274AA (High Voltage)**

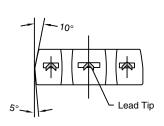
### **VERSION 1: FACILITY CODE = Y**

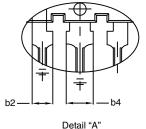






♦ 0.10 (0.25) ♠ B A ♠





Scale: 2:1

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
c <sup>(1)</sup>	0.38	0.89	0.015	0.035
D	19.80	20.80	0.780	0.819

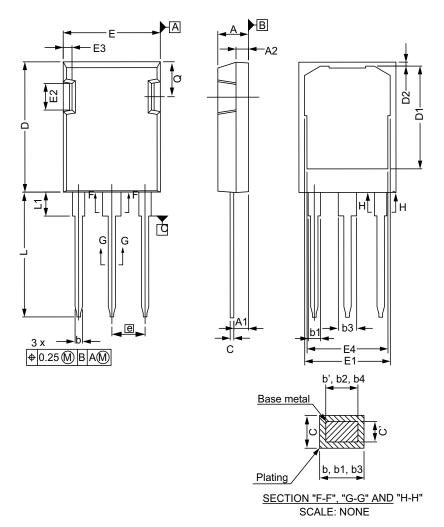
	MILLIMETERS		HES
MIN.	MAX.	MIN.	MAX.
15.50	16.10	0.610	0.634
0.70	1.30	0.028	0.051
15.10	16.10	0.594	0.634
13.30	13.90	0.524	0.547
5.45 BSC		0.215 BSC	
13.70	14.70	0.539	0.579
1.00	1.60	0.039	0.063
2.00	3.00	0.079	0.118
	15.50 0.70 15.10 13.30 5.45 13.70 1.00	15.50 16.10 0.70 1.30 15.10 16.10 13.30 13.90 5.45 BSC 13.70 14.70 1.00 1.60	15.50     16.10     0.610       0.70     1.30     0.028       15.10     16.10     0.594       13.30     13.90     0.524       5.45 BSC     0.215       13.70     14.70     0.539       1.00     1.60     0.039

### Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body
- Outline conforms to JEDEC® outline to TO-274AA
- (1) Dimension measured at tip of lead



### **VERSION 2: FACILITY CODE = N**



	MILLIMETERS		
DIM.	MIN.	MAX.	
Α	4.83	5.21	
A1	2.29	2.54	
A2	1.91	2.16	
b'	1.07	1.28	
b	1.07	1.33	
b1	1.91	2.41	
b2	1.91	2.16	
b3	2.87	3.38	
b4	2.87	3.13	
c'	0.55	0.65	
С	0.55	0.68	
D	20.80	21.10	

MILLIMETERS		
MIN.	MAX.	
16.25	17.65	
0.50	0.80	
15.75	16.13	
13.10	14.15	
3.68	5.10	
1.00	1.90	
12.38	13.43	
5.44	BSC	
3	3	
19.81	20.32	
3.70	4.00	
5.49	6.00	
	MIN. 16.25 0.50 15.75 13.10 3.68 1.00 12.38 5.44 319.81 3.70	

ECN: E20-0538-Rev. C, 19-Oct-2020

DWG: 5975

- Dimensioning and tolerancing per ASME Y14.5M-1994 Outline conforms to JEDEC® outline to TO-274AD Dimensions are measured in mm, angles are in degree

- Metal surfaces are tin plated, except area of cut



# **Legal Disclaimer Notice**

Vishay

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